

Notice of References Cited		Application/Control No. 10/674,730	Applicant(s)/Patent Under Reexamination WALTHO ET AL.	
		Examiner Siu M. Lee	Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,939,912	08-1999	Rehm, Dennis J.	327/158
*	B	US-2002/0183013 A1	12-2002	Auckland et al.	455/73
*	C	US-4,991,165	02-1991	Cronyn, Willard M.	370/278
*	D	US-6,643,522 B1	11-2003	Young, Song-Lin	455/552.1
*	E	US-2002/0080728 a1	06-2002	Sugar et al.	370/252
*	F	US-6,556,102 b1	04-2003	Sengupta et al.	333/161
*	G	US-5,757,319	05-1998	Loo et al.	342/375
*	H	US-6,915,112 B1	07-2005	Sutton et al.	455/67.13
*	I	US-5,093,929	03-1992	Stolarczyk et al.	455/40
*	J	US-5,127,101	06-1992	Rose, Jr., George D.	455/502
*	K	US-6,229,992 B1	05-2001	McGeehan et al.	455/78
*	L	US-5,757,312	05-1998	Szmurlo et al.	342/159
*	M	US-6,175,860 B1	01-2001	Gaucher, Brian Paul	709/208

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.